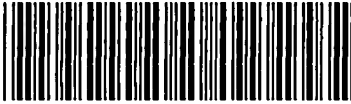


Search Notes

Application/Control No.

10/533,918

Examiner

Nguyen T. Ha

Applicant(s)/Patent under
Reexamination

OZAWA ET AL.

Art Unit

2831

SEARCHED

Class	Subclass	Date	Examiner
361	523-525	2/26/2007	NH
	527-534		
	516-519		
29	25.01		
	25.03		
252	62.2		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH (SEE SEARCH HISTORY)	2/26/2007	NH